

Search Notes

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Victoria W. Chen

Applicant(s)/Patent under
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BEAUPRE, JEAN M.

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SEARCHED

Class	Subclass	Date	Examiner
606	169,1	5/16/2007	VWC
604	21-22	5/16/2007	VWC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated search	5/16/2007	VWC